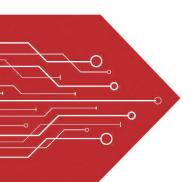
MSKSEMI















ESD

TVS

TSS

MOV

GDT

PLED

Broduct data sheet



Features

Ideal for printed circuit board

Reliable low cost construction utilizing molded plastic technique

High temperature soldering guaranteed: 260°/10 seconds at 5 lbs.,

(2.3kg) tension

Small size, simple installation

High surge current capability

Mechanical Data

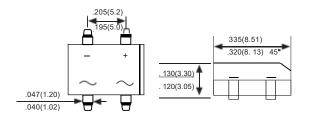
Case: JEDEC DBS Molded plastic body

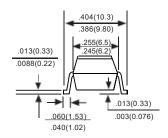
Terminals: Solder plated, solderable per MIL-STD-750, Method 2026

Polarity: Polarity symbol marking on body

Mounting Position: Any

Weight: 0.02 ounce, 0.4 grams





Dimensions in inches and (millimeters)

REEL SPECIFICATION

P/N	PKG	QTY
DB301S-DB307S	DBS	1500

Maximum Ratings And Electrical Characteristics

Ratings at 25°C ambient temperature unlss otherwise specified.

Single phase half-wave 60Hz, resistive or inductive load, for capacitive load current derate by 20%.

Parameter	SYMBOLS	DB301S	DB302S	DB303S	DB304S	DB305S	DB306S	DB307S	UNITS
Maximum repetitive peak reverse voltage	VRRM	50	100	200	400	600	800	1000	V
Maximum RMS voltage	V _{RMS}	35	70	140	280	420	560	700	V
Maximum DC blocking voltage	VDC	50	100	200	400	600	800	1000	V
Maximum average forward rectified current at T _A =40°C	l _{F(AV)}				3.0				А
Peak forward surge current, 8.3ms single half sine-wave superimposed on rated load (JEDEC Method)	lгsм	85					Α		
Maximum instantaneous forward voltage drop per leg at 3.0A	V _F	1.1					V		
Maximum DC reverse current T _A =25°C at rated DC blocking voltage T _A =125°C	l R	10 500					pA pA		
I ² t Rating for Fusing (t<8.3ms)	l2 t	10.4					A ₂ s		
Operating temperature range (Note1)	C				25				рF
Typical Thermal Resistance (Note2)	Rеja				110				°C/W
Operating temperature range	Тı			- [55 to +15	0			°C
storage temperature range	Тѕтс	-55 to +150				°C			

NOTES: 1. Measured at 1.0 MHz and applied reverse voltage of 4.0 V DC.

 $2. Thermal\ resistance\ from\ junction\ to\ ambient\ mounted\ on\ P.C.B. with 0.5*0.5" (13*13\,mm)\ copper\ pads.$



Ratings And Characteristic Curves

FIG. 1-TYPICAL FORWARD CURRENT DERATING CURVE

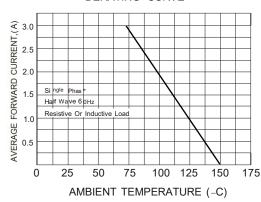


FIG. 2 - MAXIMUM NON-REPETITIVE FORWARD SURGE CURRENT

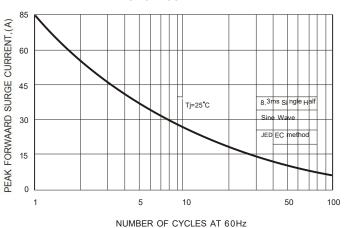


FIG. 3-TYPICAL FORWARD

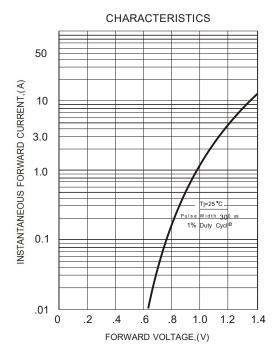
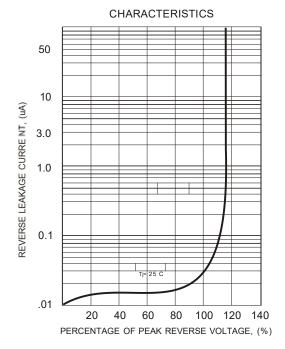


FIG.4-TYPICAL REVERSE





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